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Development of LPP-EUV source for HVM EUVL

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Outline

1. Introduction

2. Engineering Test source

- **1st Generation (ETS) device: System experiment**
 - Operation Data
- **10Hz device: Critical issue experiment**
 - Vaporization experiment
 - Ionization experiment
 - Magnetic mitigation
 - Pre-pulse and high CE

3. HVM EUV light source

- **Product roadmap**
- **2nd Generation device: Development status**
 - Configuration
 - Latest status

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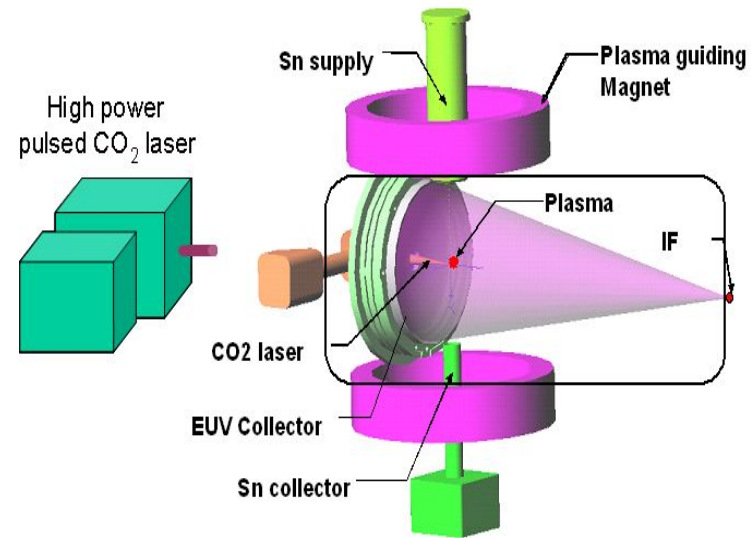
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EUV sources

LPP: CO₂ laser and Sn source

- ✓ High power pulsed CO₂ laser
- ✓ Magnetic field plasma mitigation
- ✓ Pre-Pulse plasma technology



Type	LPP
Power (at present) peak/average	104W/21W
Plasma	No electrode
Mitigation	Pre pulse + Magnet
Life limitation	(several 1000 hr)
Remark	<ul style="list-style-type: none"> • Theoretically no limit • Engineering works still to be done



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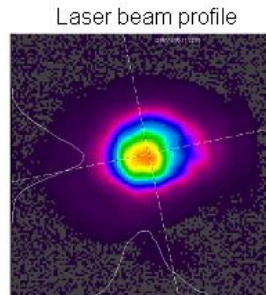
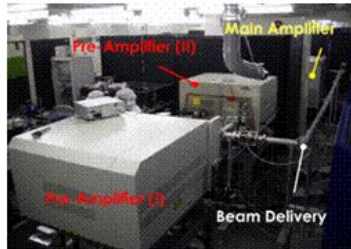
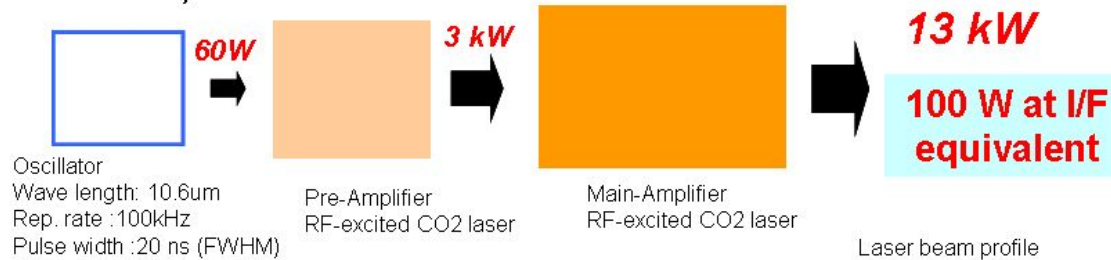
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ETS system configuration

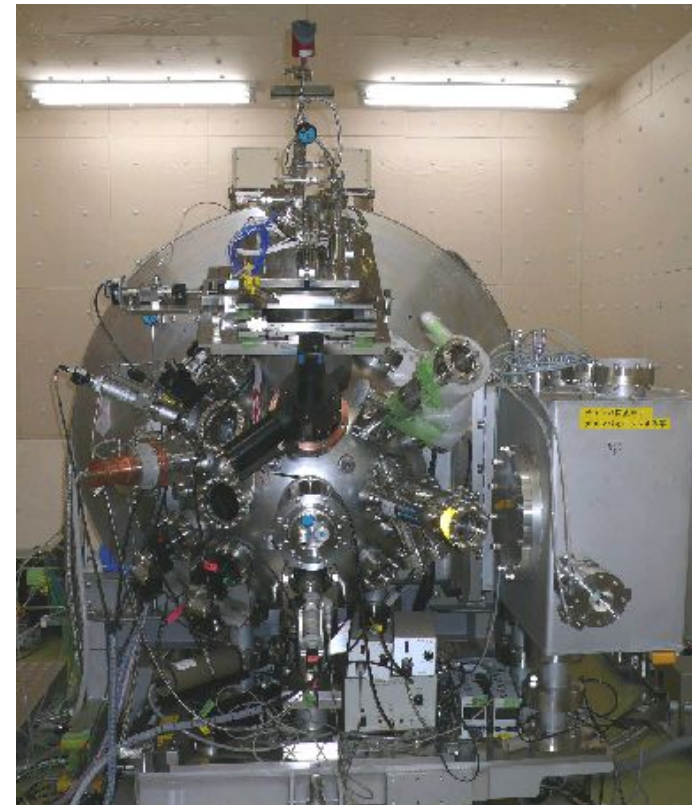
System layout

■ Laser System



Laser Power: 13 kW
 Pulse Width: 20 ns
 Repetition Rate: 100 kHz
 Pulse energy stability : 2% (3s, 500 pulses)

■ EUV chamber



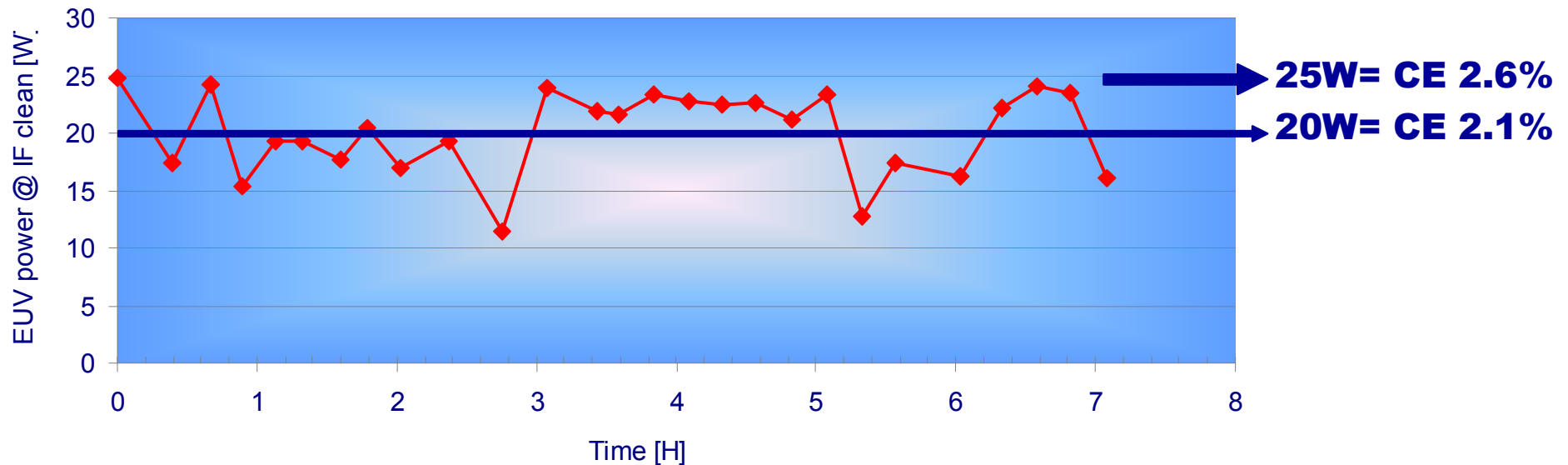
System operation Data (ETS device)

	SPIE 2010 (Feb.2010)	EUV Symposium (Oct.2010)	Latest Data (Feb,2011)
EUV power (@ I/F)	69 W	104 W	42 W
EUV power (clean @ I/F)	33 W	50 W	20 W
Duty cycle	20 %	20 %	5%
Max. non stop op. time	>1 hr	<1 hr	>7 hr
Average CE	2.3 %	2.5 %	2.1%
Dose stability :simulation	(+/- 0.15%)		-
Droplet diameter	60μm	60μm	30μm
CO₂ laser power	5.6 kW	7.9 kW	3.6kW

System operation result on ETS

➤ Long time system operation demonstrated

- Operation duration: **7 hours**
- Droplet **30 μm diameter**
- Full repetition rate: **100 kHz**
- In burst clean power: **20W (average)**
25W (max)



Conditions;

Control: Droplet position control ON, EUV energy control OFF

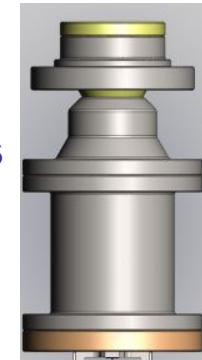
CO₂ laser = 3.6kW @ 100kHz

Duty=5% (50msecON, 950msecOFF)

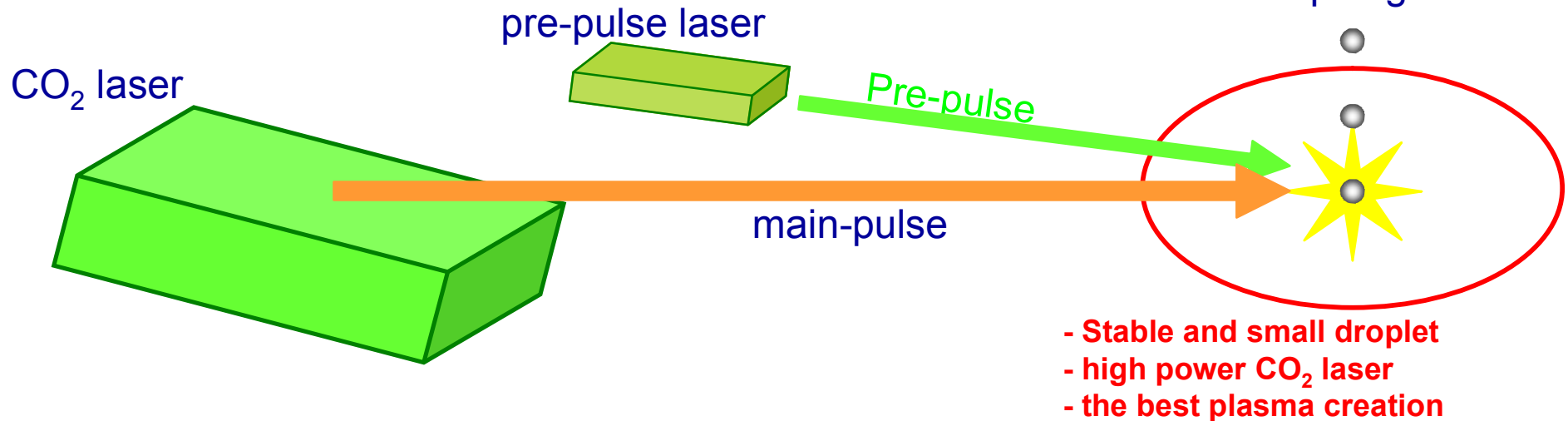
Conclusion of ETS device experiment

“ETS experiment clarified 3 key challenges are essential”

- ✓ **CE (Conversion Efficiency) improvement**
- ✓ **Debris mitigation = Stability and size of droplets**
- ✓ **CO₂ laser load = power x duty**



Droplet generator



- Stable and small droplet
- high power CO₂ laser
- the best plasma creation

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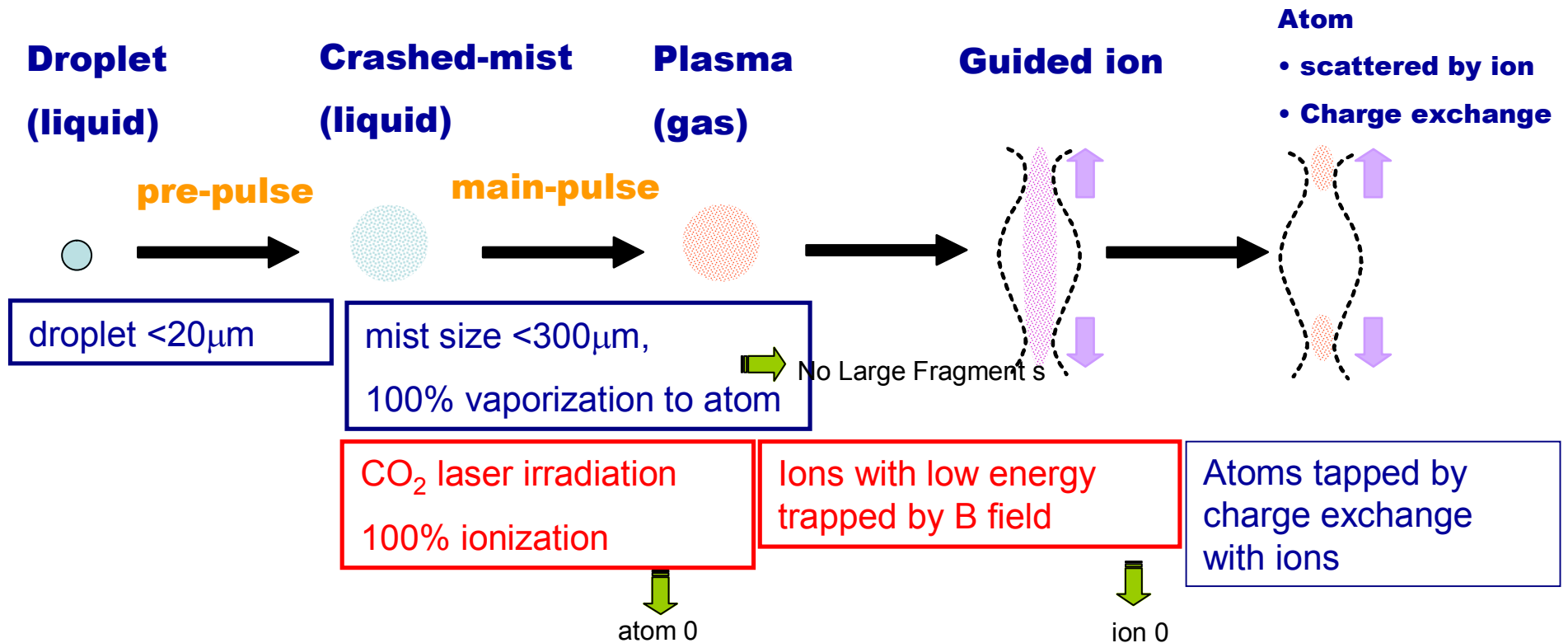
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Collector mirror protect Concept

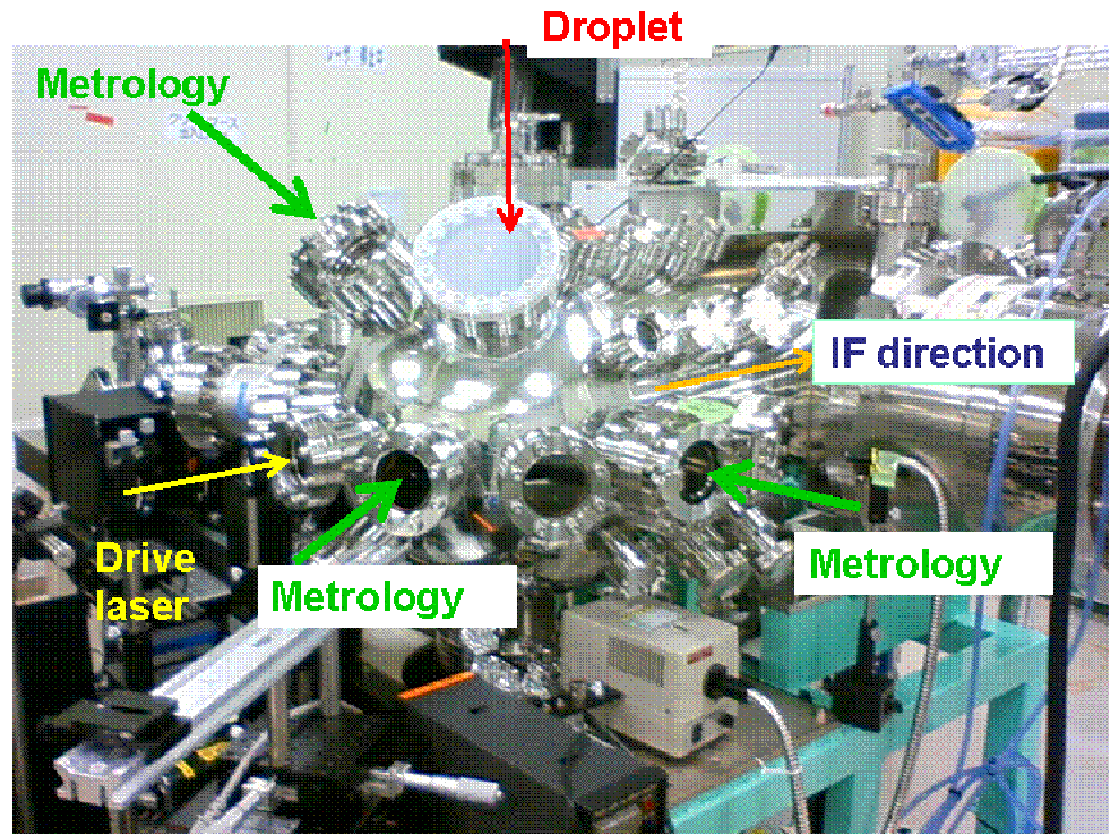
All Sn atoms should be ionized.

- ① Magnet field is effective for guiding ions not to going to mirror
- ② All Sn fragments and atoms are needed to be ionized

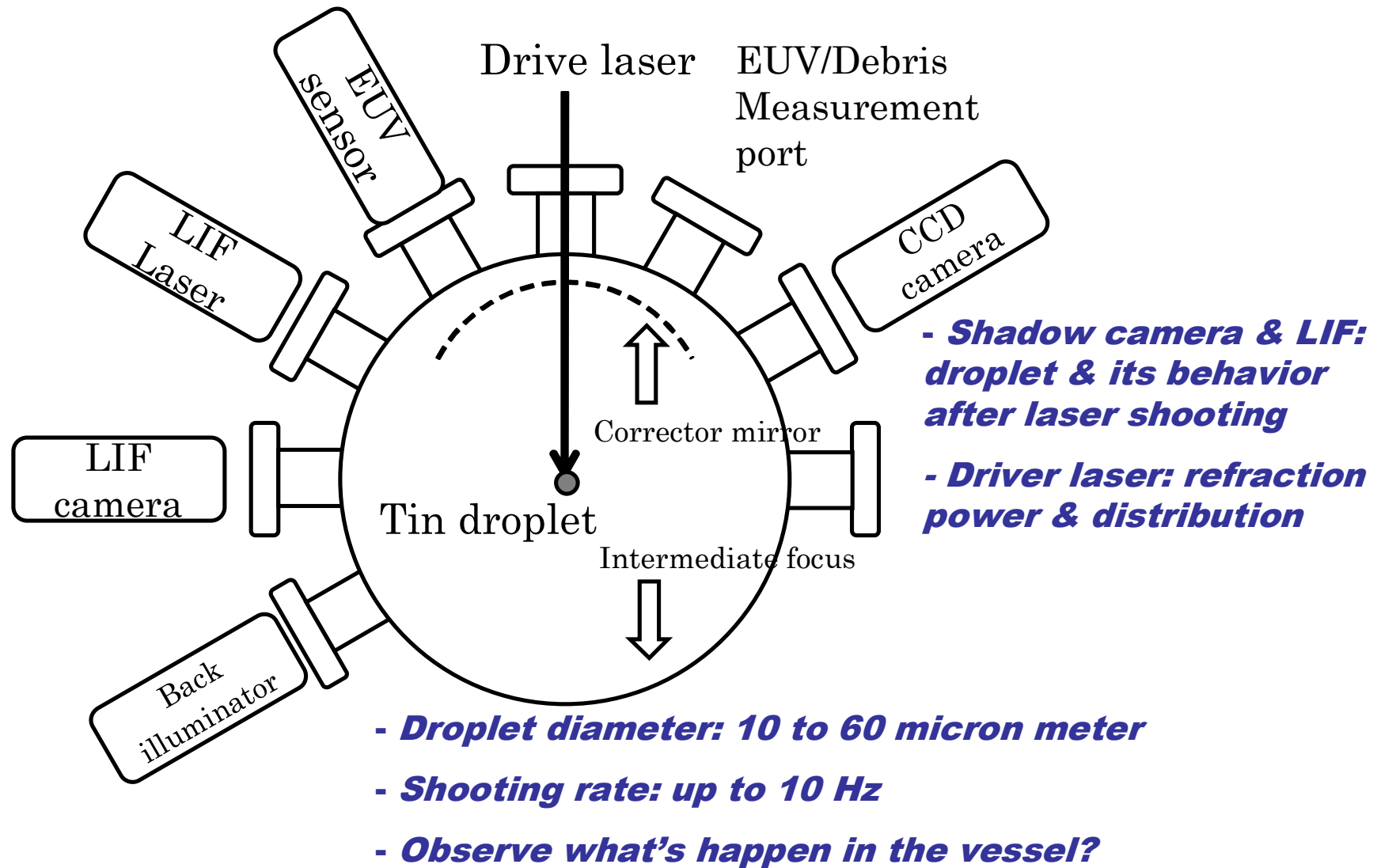


Critical issue investigation with 10Hz device

- *Double pulse optimization*
- *Debris mitigation mechanism*
- *Higher CE investigation*



Setup configurations



Droplet shooting scheme

Proper pre-pulse condition

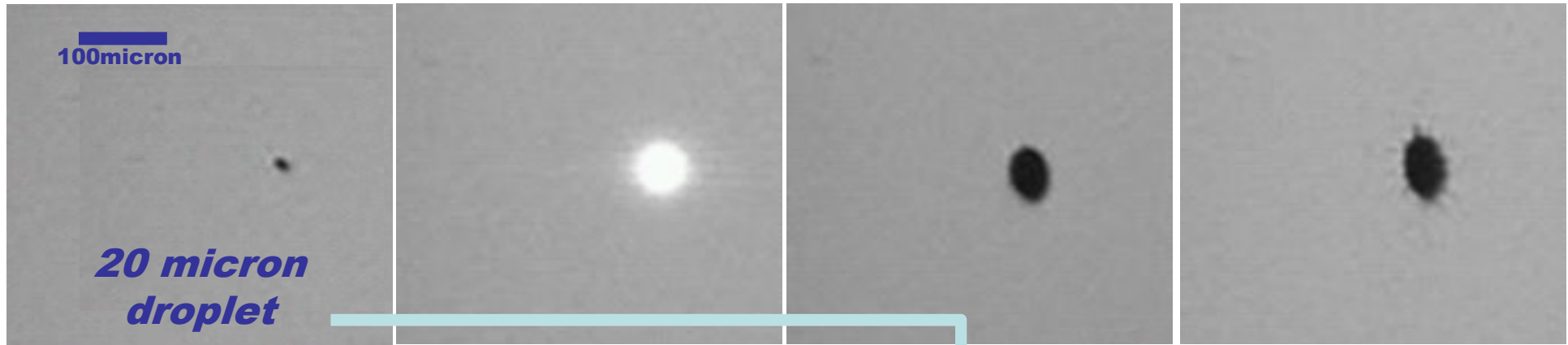
pre-pulse irradiation

Main pulse laser
 / EUV emission

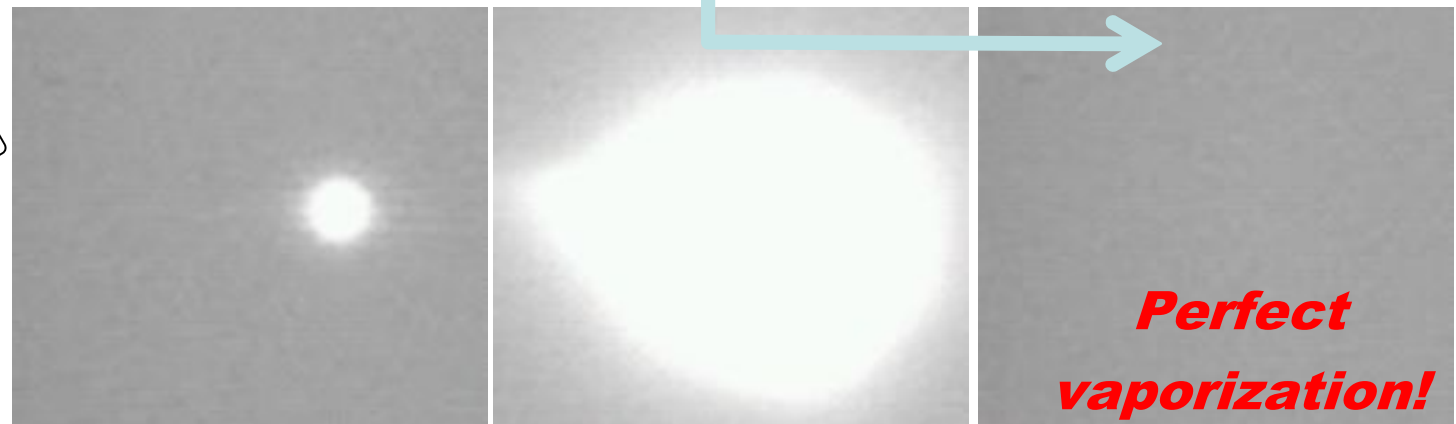
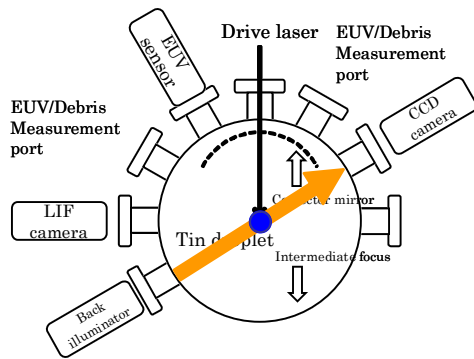
after EUV emission

Time

a) without main-pulse laser



b) with main-pulse laser

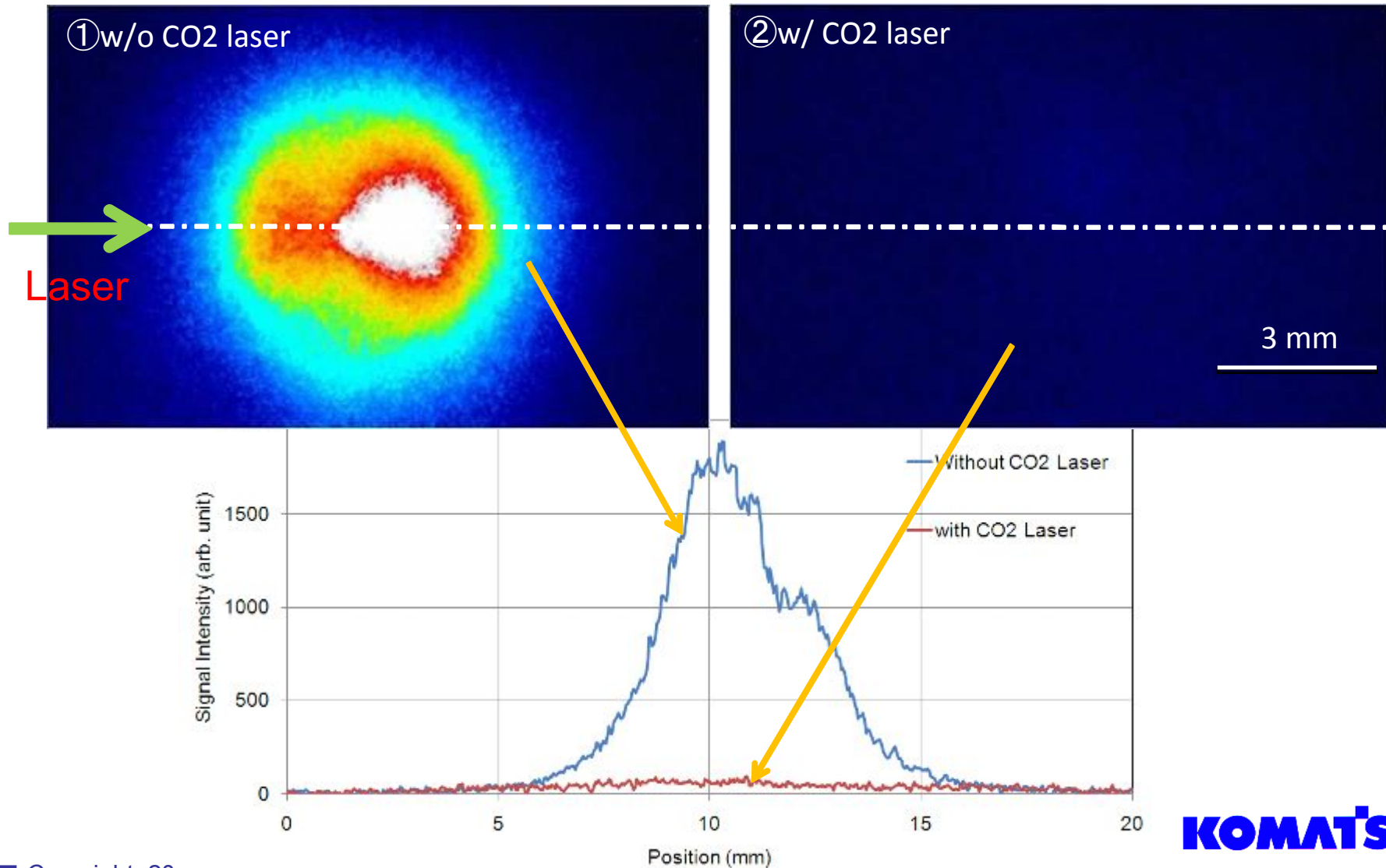


**Perfect
 vaporization!**

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Atom measurement by LIF - 2

Remaining atoms was estimated by subtracting
w/ CO2 vs w/o CO2 measurement

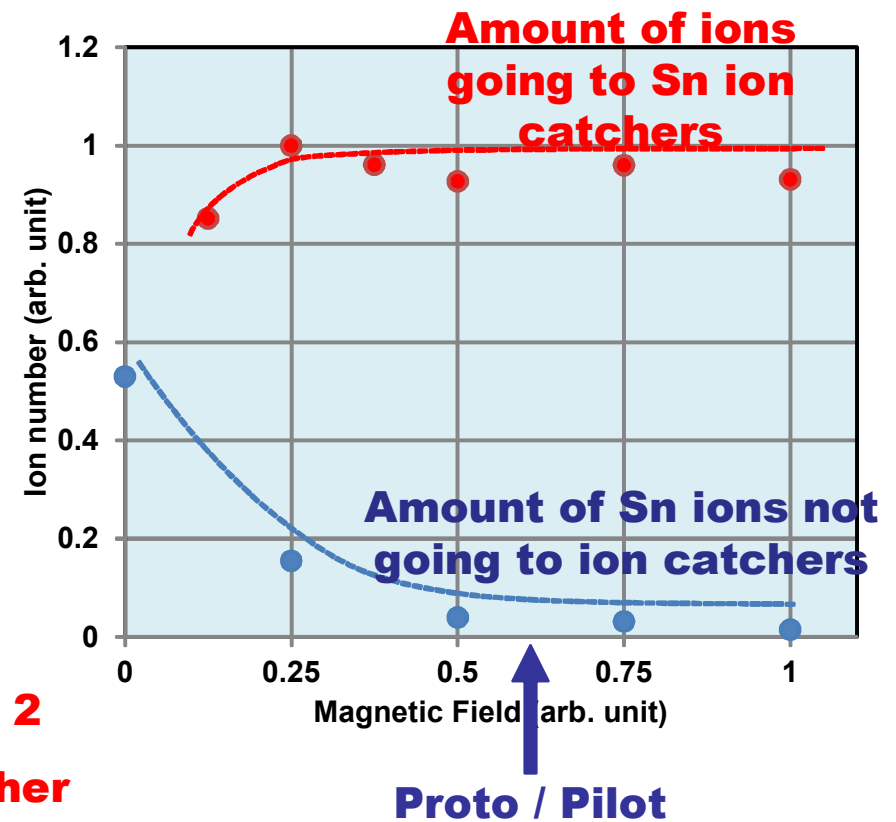
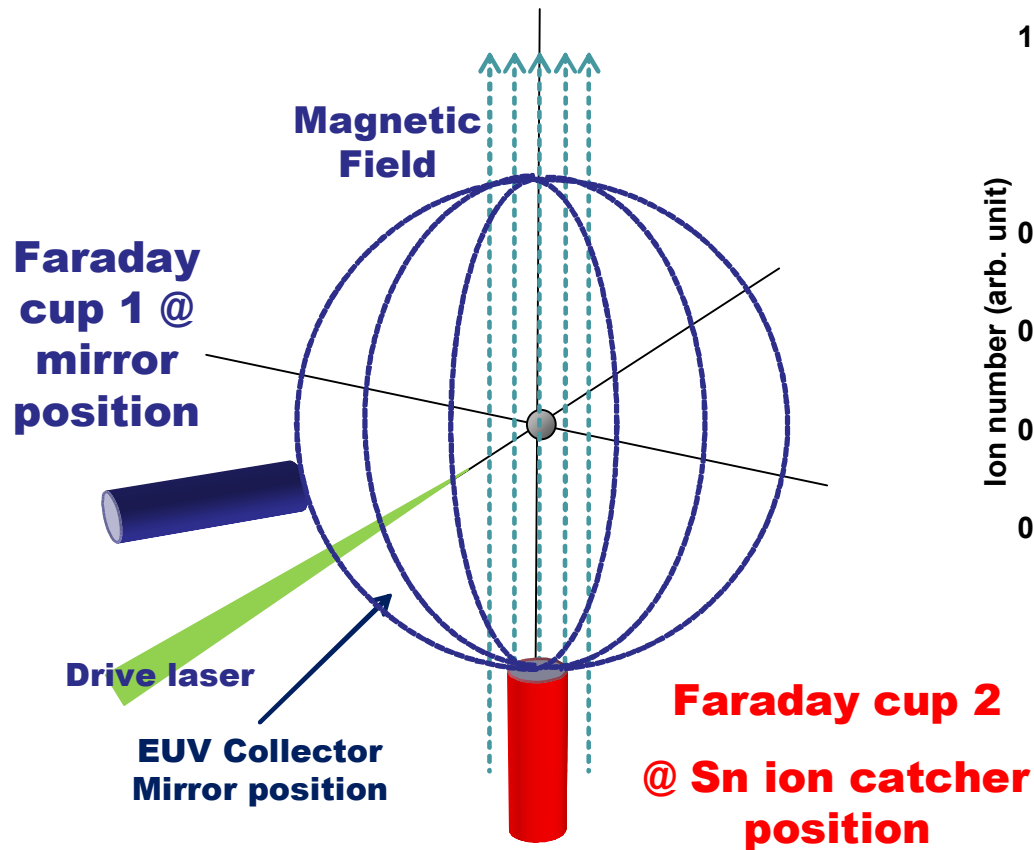


Ion Measurements by Faraday cups

- Amount of ion is measured by Faraday cup



- **>99% Sn go to Sn ion catcher !!**

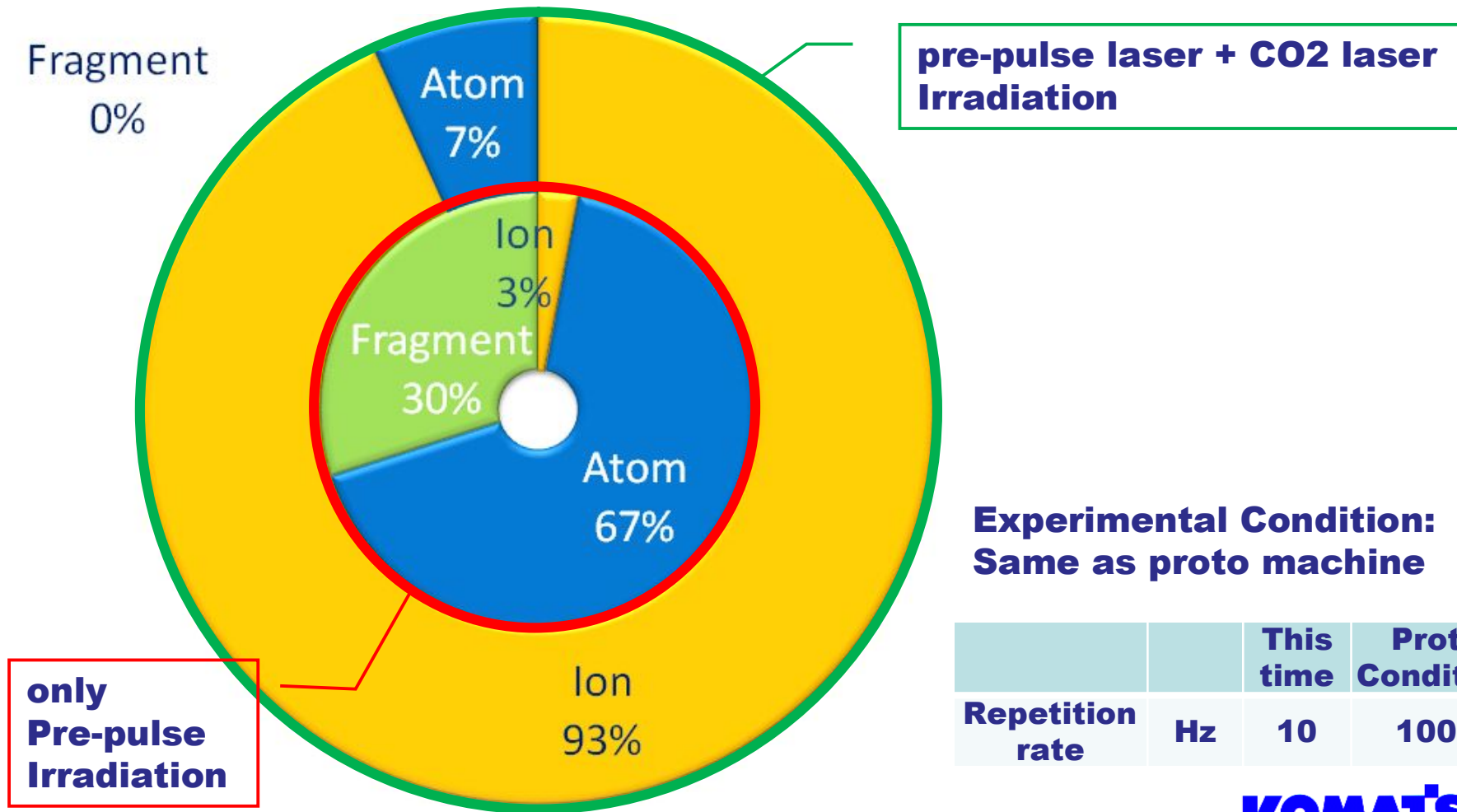


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Results Summary

➤ Sn molecule measurement results

- ✓ pre-pulse laser + CO2 laser irradiation : ionized 93% of Sn
- ✓ Only pre-pulse laser irradiation : ionized 3% of Sn



pre-pulse laser + CO2 laser irradiation

only Pre-pulse Irradiation

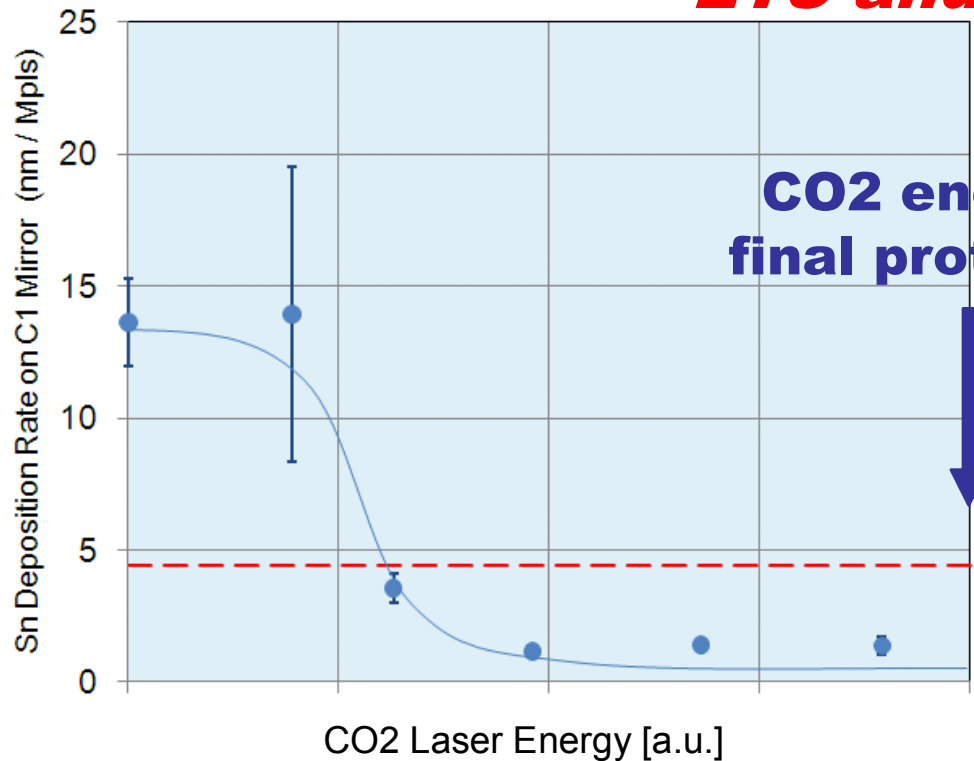
**Experimental Condition:
Same as proto machine**

		This time	Proto Condition
Repetition rate	Hz	10	100k

Clean operation feasibility proven

- **Estimated deposition and cleaning rates**
 - ✓ **Deposition rate:** 1.2 nm / Mpls*
 - ✓ **Cleaning rate:** 4.4 nm / Mpls**

Clean operation is proven by test data with ETS and 10Hz source



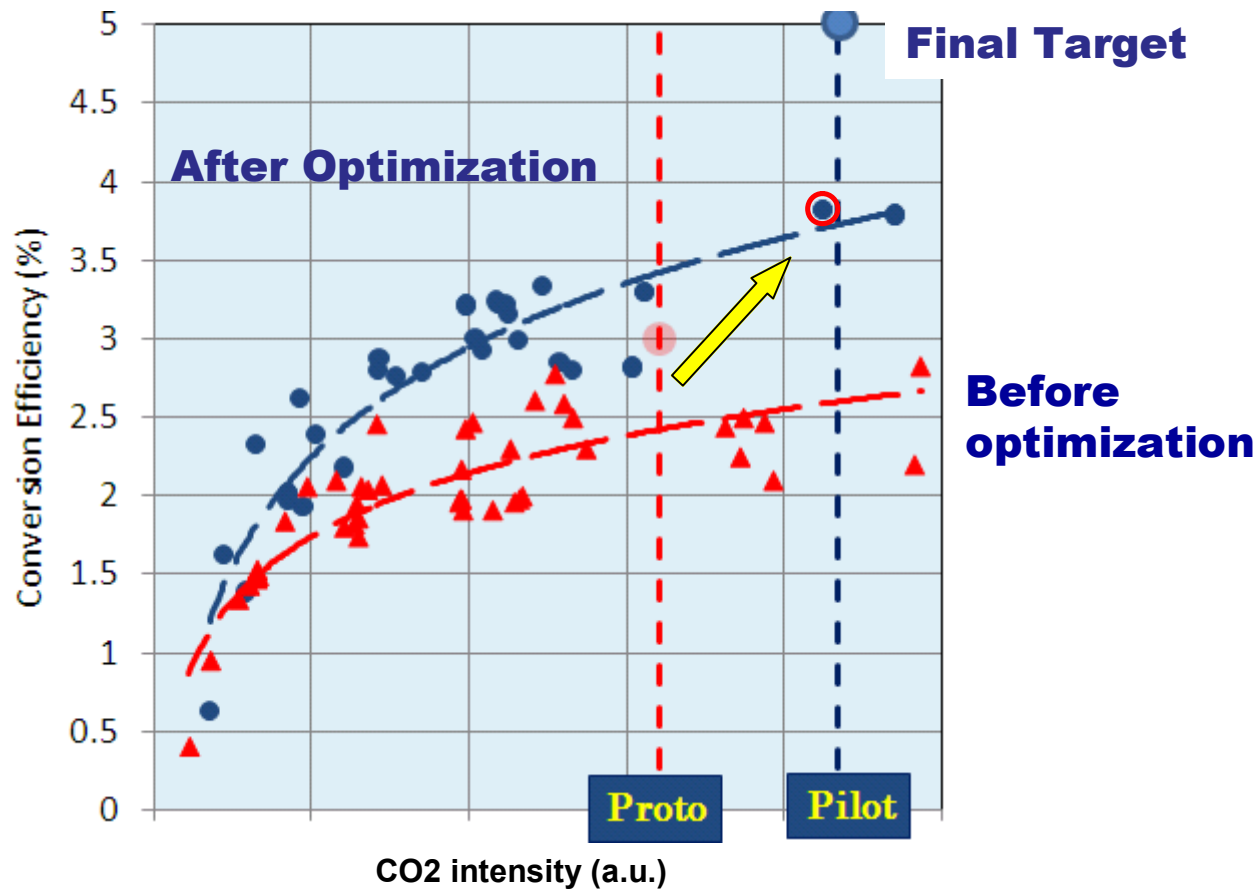
- * Estimation of Sn atom dispersion : isotropic
- ** Estimation based on experimental data under pilot conditions

New champion data of **CE = 3.8%** (Aug.2011)

➤ After CE optimization

✓ 3.3% → **3.8%** (@ pilot condition)

Conversion Efficiency vs CO2 Laser Intensity





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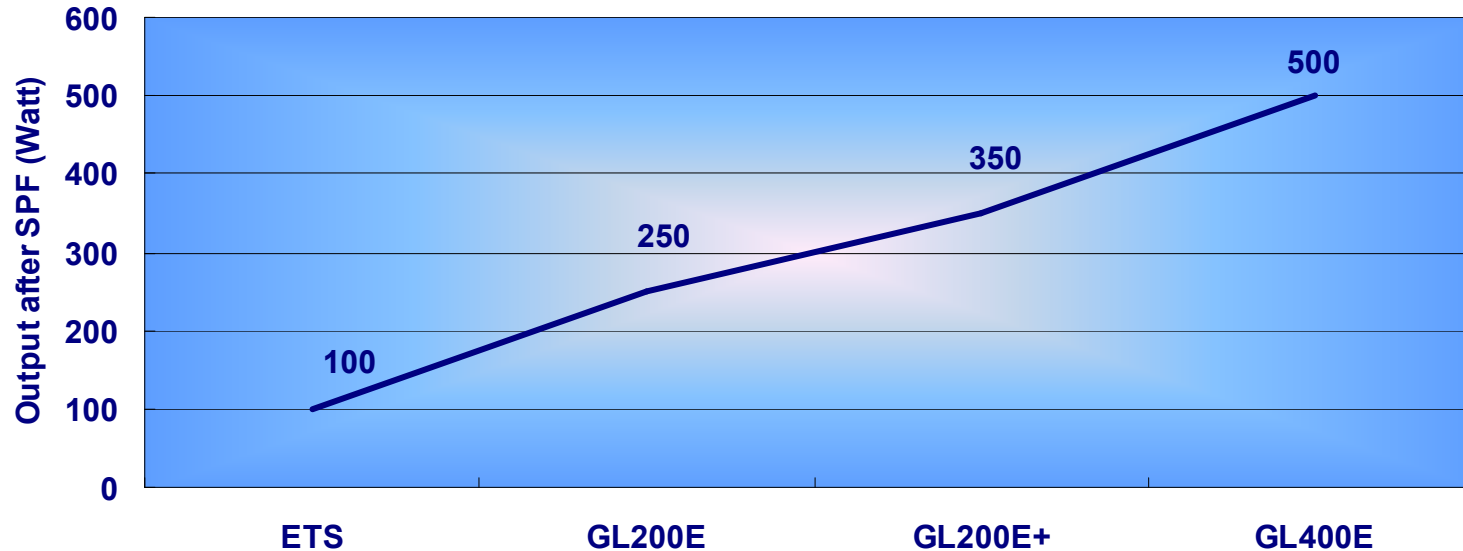
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Clean power roadmap



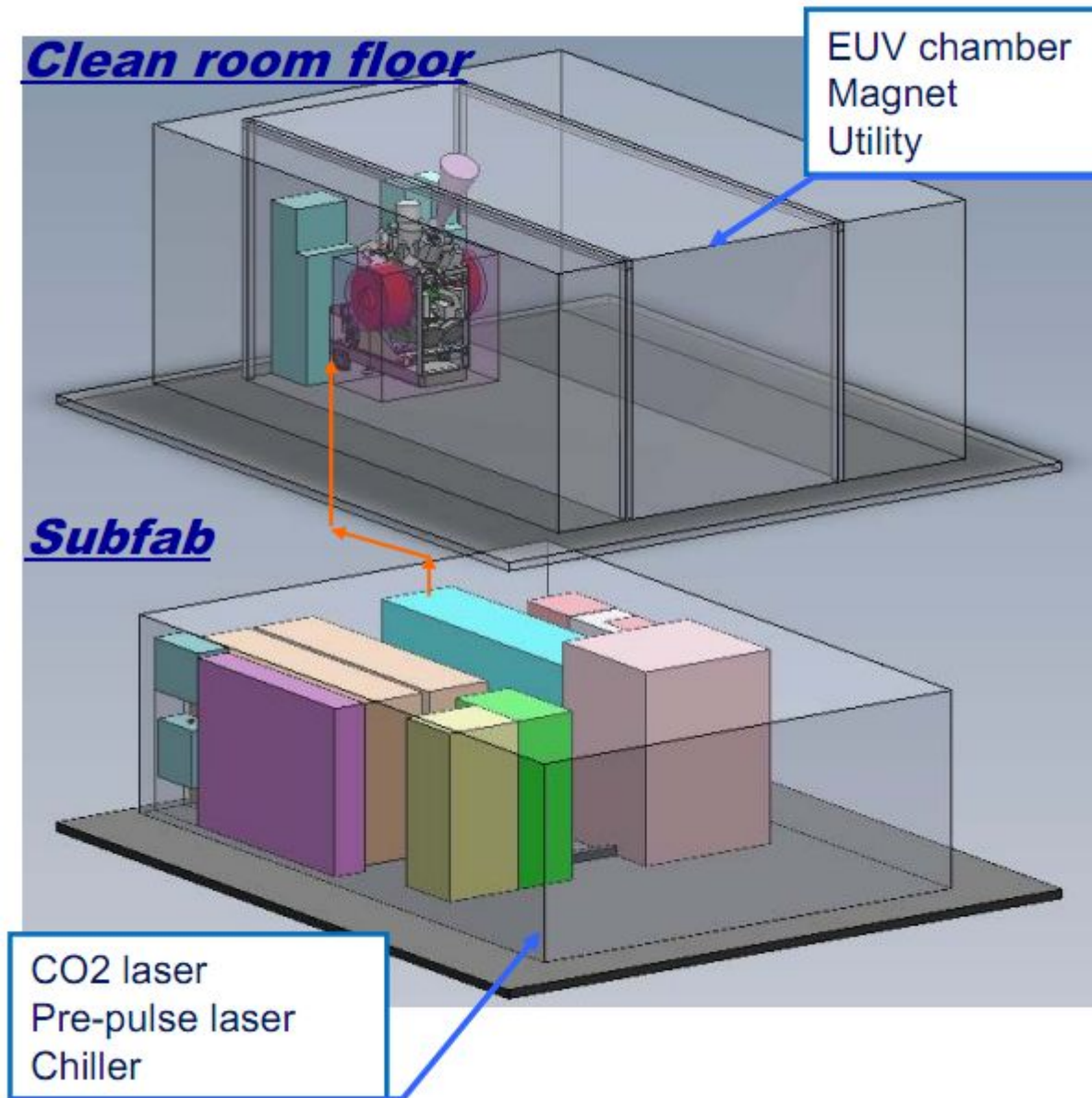
EUV model		ETS	GL200E	GL200E+	GL400E
Drive laser power	kW	10	23	33	40
Conversion efficiency	%	3.0	5.0	5.0	6.0
C1 mirror collector angle	sr	5.5	5.5	5.5	5.5
efficiency*	%	74	74	74	74
C1 mirror reflectivity	%	(50)	57	57	57
Optical transmission	%	95	95	95	95
SPF (IR, DUV)	%	N/A**	62	62	62
Total EUV power (after SF	W	100	250	350	500

* Against hemisphere (Calculation base)

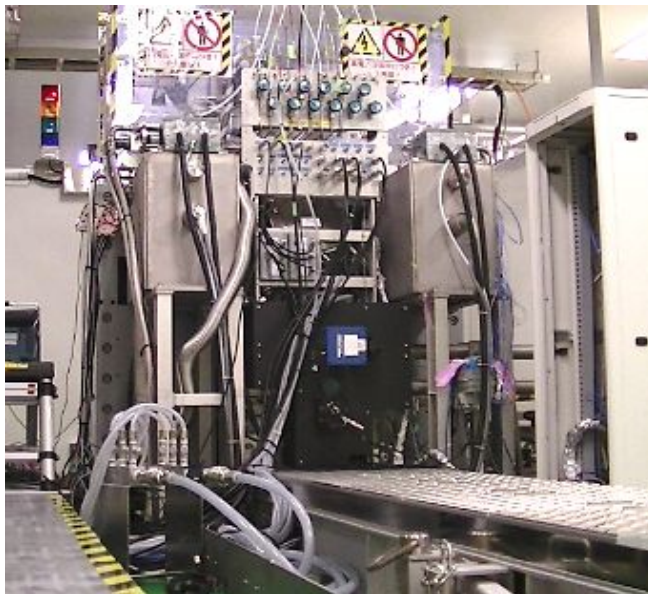
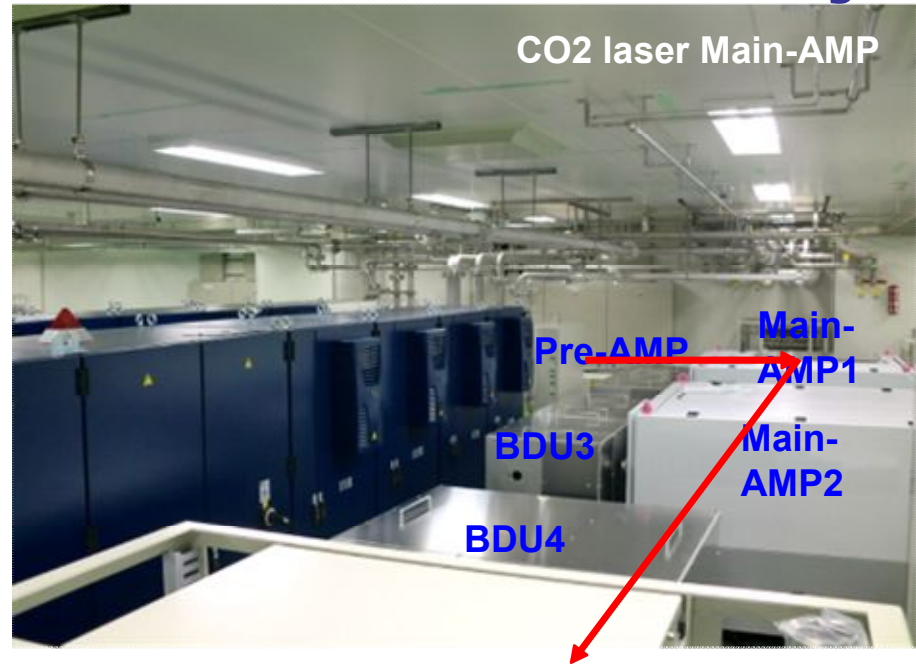
** w/o SPF



GL200E system overview



GL200E proto constructed at Hiratsuka facility



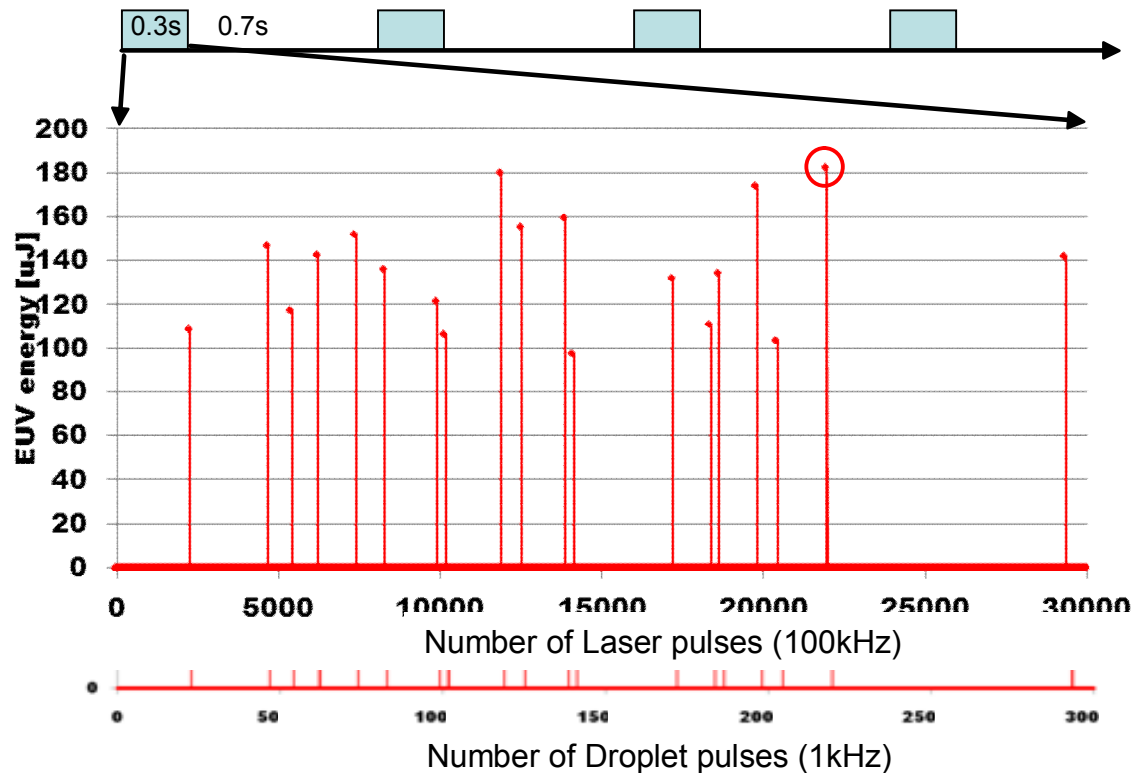
Real 1st EUV light was observed on proto !

✓ Max EUV energy = 0.182mJ, CE=0.6% (Energy 18W equiv.@100kHz)

Improvement with plasma shield

Rate of success hit
= 6.3% (=19 / 300)

Miss hit remain, seems by instability of DL acceleration voltage



Operation conditions

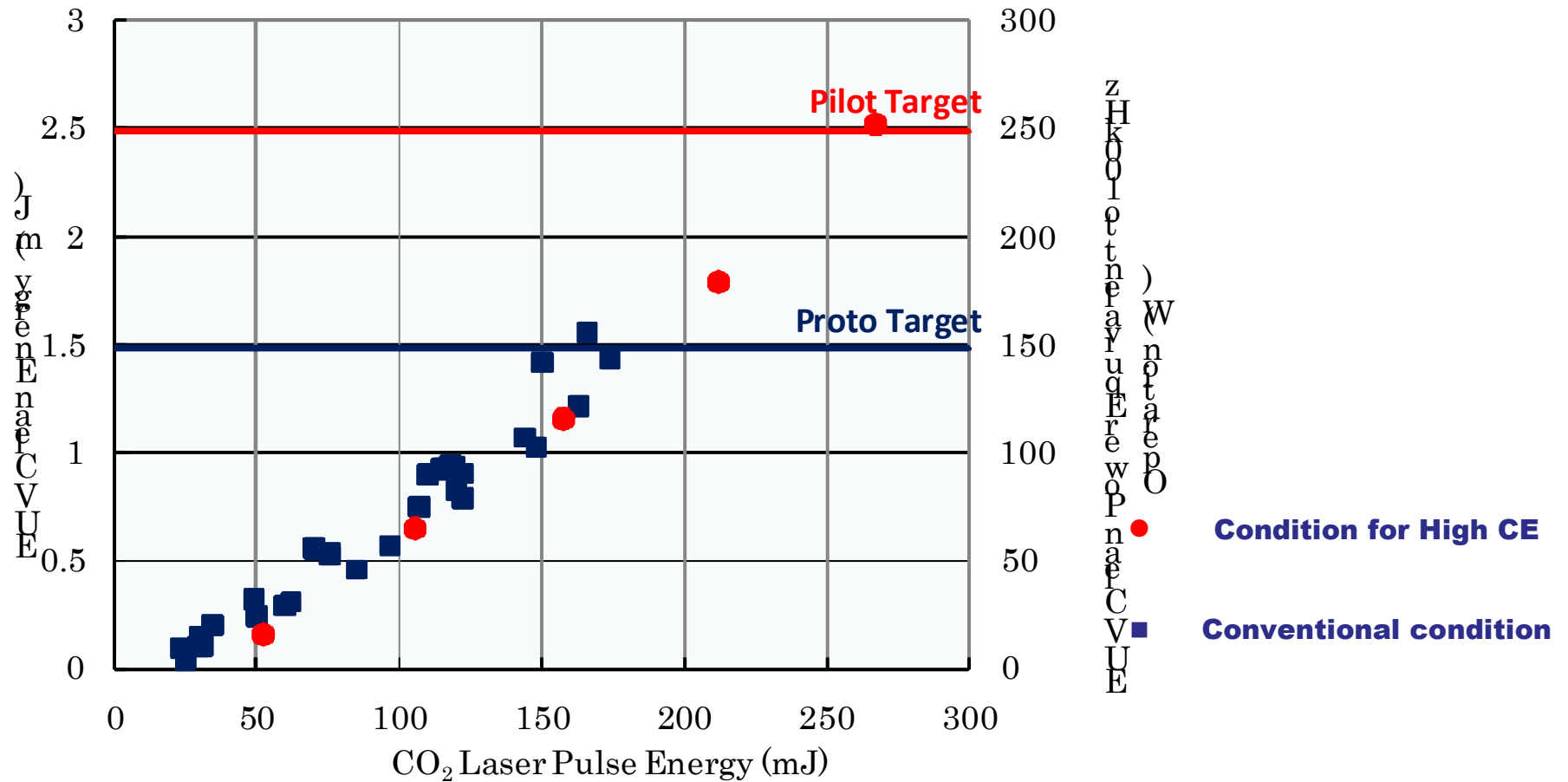
Duty=30% (0.3 sec ON (300pls DL / 30,000pls Laser) , 0.7sec OFF)

- CO₂ laser power = 3.0kW 100kHz @ Plasma
- Pre-pulse laser power = 0.1kW 100kHz @ Plasma
- DLG = 33 μm 1kHz

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EUV Output Power vs CO2 Input Power

- We achieved 2.5mJ EUV output which correspond to 250W clean power





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Summary

- **1st generation integrated setup LPP source (ETS) and 10 Hz device:**
 - One order smaller fragment (droplet size reduction from 60 μ m to 30 μ m) extends operation time to 7 hours under 20W(clean power @I/F, 5%duty) level operation.
 - 10Hz experiment proved debris mitigation concept experimentally. That is; proper pre-ionization and main ionization make >93% ionization. This technology enables clean light source with combination with magnetic field.
 - 10Hz experiment clarify CE (Conversion Efficiency) improvement, with <20 μ m droplet we found the region where CE >3.8% and perfect vaporization are simultaneously possible.

- **2st generation LPP source (GL200E):**
 - Concept of design and outline is reported.
 - Our final goal of GL-200E is 250W and the feasibility is supported by high CE experimental data.
 - We observed 1st EUV light on proto source with 18W equivalent level at present. Next target is 50W level demonstration until 1Q 2012.

Acknowledgments

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